FORM PTO-1449/A and B (Modified)	APPLICATION NO.: Unassigned	ATTY. DOCKET NO.: \$1022/8628
INFORMATION DISCLOSURE	FILING DATE: Herewith	
STATEMENT BY APPLICANT	APPLICANT: S1022/8628	
Sheet 1 of 1	GROUP ART UNIT: Unassigned	EXAMINER: Unassigned

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Initials#	No	the item (book, magazine, journal, serial, symposium, catalog, etc.), date, relevant page(s), volume-	(Y/N)
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EXAMINER	DATE CONSIDERED 7/24	184

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FORM PTO-1449/A and B (Modified) APPLICATION NO.: 09/853,890 ATTY. DOCKET NO.: \$1022/8628 FILING DATE: May 11, 2001 APPLICANT: Luc WUIDART GROUP ART UNIT: 2816 EXAMINER: Unassigned

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FORM PTO-1449/A and B (Modified)

INFORMATION DISCLOSURED STATEMENT BY APPLICANT

PPLICATION NO.: 09/853,890

ATTY. DOCKET NO.: \$01022.80628.US

FILING DATE:

May 11, 2001

CONFIRMATION NO.: 6158

APPLICANT:

Luc WUIDART

Sheet 1 of 2

EXAMINER: Not yet assigned

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*a copy of this reference is not provided as it was previously cited by or submitted to the office in a prior application, Serial No. ___, filed ___, and relied upon for an earlier filing date under 35 U.S.C. 120 (continuation, continuation-in-part, and divisional applications).

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)		···		U.S.	PATENT DOCUMENTS					
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^{*} a copy of this reference is not provided in accordance with the waiver notice of July 11, 2003 from the Patent and Trademark Office.